

QUAD MONOLITHIC SPST CMOS/D-MOS ANALOG SWITCH

ORDERING INFORMATION

Quad SPST, Logic '0' ON Break-Before-Make	16-Pin Plastic DIP	16-Pin Ceramic DIP
Commercial Temp. Range	CDG201CJ	—
Industrial Temp. Range	CDG201BJ	CDG201BK
Military Temp. Range	—	CDG201AK

FEATURES

- High OFF Isolation, 66 dB @ 10MHz
- Wide Bandwidth Switches, 0.9 x DC @ 100MHz
- Low Channel-to-Channel Crosstalk, -80 dB @ 10MHz
- TTL Compatible
- Industry Standard Pin-Out

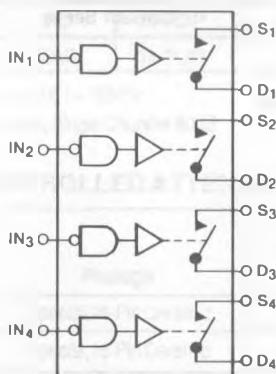
DESCRIPTION

The Topaz Semiconductor CDG201 Analog Switch features TTL compatible input logic and wide-band Lateral D-MOS switches on a single chip. The on-chip reference used for TTL compatibility gives the added advantage of constant logic switching over a wide range of supply voltages and temperature without a separate power supply. Industry standard pin-out makes the CDG201 particularly suitable for replacement of existing analog switches and at the same time upgrading high frequency performance.

NOTE

All devices contain diodes to protect inputs against damage due to high static voltages or electric fields; however, it is advised that precautions be taken not to exceed the maximum recommended input voltages. All unused inputs must be connected to an appropriate logic level (V_{DD} or GND).

FUNCTIONAL BLOCK DIAGRAM

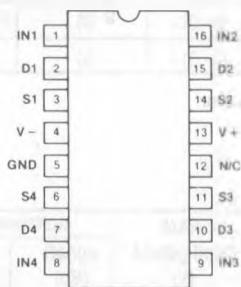


Four SPST Switches per Package
Switches shown in Logic "1" Input Position

APPLICATIONS

- Glitch-Free Analog Switches
- RF & Video Switches
- Track and Hold Switches
- Sample and Hold Switches

PIN CONFIGURATION



LOGIC TABLE

Logic	Switch
0	ON
1	OFF

Logic '0' $\leq 0.8V$
Logic '1' $\geq 2.4V$

ABSOLUTE MAXIMUM RATINGS

V-	Negative Supply Voltage	-20V
V+	Positive Supply Voltage	+20V
V _{IN}	Control Input Voltage Range	V+ +0.3V, V- -0.3V
I _L	Continuous Current, any Pin Except S or D	20 mA
I _S	Continuous Current, S or D	30 mA
I _S	Peak Pulsed Current, S or D, 80 μ sec, 1%, Duty Cycle	90 mA
T _J	Junction Temperature Range	-55 to +125°C
T _S	Storage Temperature Range	-55 to +125°C
P _D	Power Dissipation (derate at 5.5mW/ $^{\circ}$ C, above +85°C)	500 mW

RECOMMENDED OPERATING CONDITIONS

V-	Negative Supply Voltage	-8.0 to -15V
V+	Positive Supply Voltage	+8.0 to +15V
V _{IN}	Control Input Voltage Range	0 to +5V
T _{OP}	Operating Temperature (A Suffix)	-55 to +125°C
	(B Suffix)	-25 to +85°C
	(C Suffix)	0 to +70°C

ELECTRICAL CHARACTERISTICS ($T_A = +25^{\circ}\text{C}$, $V- = -15\text{V}$, $V+ = +15\text{V}$ per channel, unless otherwise noted)

#	SYMBOL	PARAMETER	MIN	TYP	MAX	UNITS	TEST CONDITIONS
1	S T A T I C	Analog Signal Range	-10		+10	V	
2		Switch ON Resistance		40	80	Ω	$V_S = -10\text{V}$ $V_S = +2.0\text{V}$ $V_S = +10\text{V}$
3				45	80		
4				100	160		
5		High Level Input Voltage	2.4			V	
6		Low Level Input Voltage			0.8		
7		Logic Input Leakage Current		0.01	0.1	μA	$V_{IN} = +2.4\text{V}$
8				0.02	0.1		$V_{IN} = +15\text{V}$
9		Switch OFF Leakage Current		0.2	5.0	nA	$V_D = +10\text{V}, V_S = -10\text{V}$
10				0.4	5.0		$V_S = +10\text{V}, V_D = -10\text{V}$
11	I-	Negative Supply Quiescent Current	-0.3	-1.0		mA	$V_{IN} = 0$ or +2.4
12	I+	Positive Supply Quiescent Current	0.6	2.0			
13	t _{ON}	Switch Turn-On Time	400	600		nSec	See Switching Times
14	t _{OFF}	Switch Turn-OFF Time	70	300			Test Circuit
15	O _{IRR}	OFF Isolation, Rejection Ratio	60	66		dB	f = 10 MHz
16	C _{CCR}	Cross-Coupling Rejection Ratio		80			R _L = 50 Ω
17	C _d	Drain-Node Capacitance		0.3		pF	$V_D = V_S = 0$
18	C _s	Source-Node Capacitance		3.0			$f = 1\text{MHz}$ $V_{IN} = +2.4\text{V}$

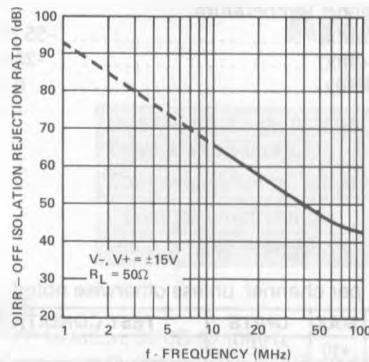
ELECTRICAL CHARACTERISTICS ($V- = -15\text{V}$, $V+ = +15\text{V}$, per channel unless otherwise noted)

LIMITS AT TEMPERATURE EXTREMES

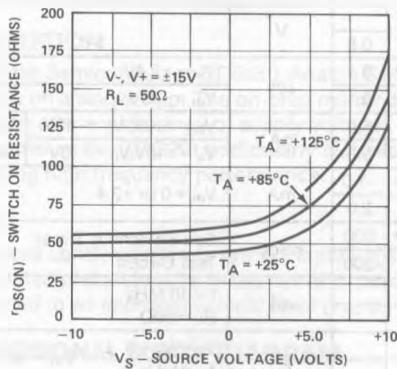
#	SYMBOL	PARAMETER	MAXIMUM @ $T_A =$					UNITS	TEST CONDITIONS
			-55°C	-25°C	+70°C	+85°C	+125°C		
1	S T A T I C	Analog Signal Range	± 10	± 10	± 10	± 10	± 10	V	
2		Switch ON Resistance	80	80	120	120	150	Ω	$V_S = -10\text{V}$ $V_S = +2.0\text{V}$ $V_S = +10\text{V}$
3			80	80	120	120	150		
4			160	160	240	240	300		
5		Logic Input Leakage Current	0.1	0.1	1.0	1.0	10	μA	$V_{IN} = +2.4\text{V}$ $V_{IN} = +15\text{V}$
6			0.1	0.1	2.0	2.0	20		
7		Switch OFF Leakage Current	5.0	5.0	100	100	1000	nA	$V_D = +10\text{V}, V_S = -10\text{V}$ $V_S = +10\text{V}, V_D = -10\text{V}$
8			5.0	5.0	100	100	1000		
9	I-	Supply Quiescent Currents	-1.0	-1.0	-1.0	-1.0	-1.0	mA	$V_{IN} = 0$ or +2.4
10	I+		2.0	2.0	2.0	2.0	2.0		

TYPICAL PERFORMANCE CHARACTERISTICS ($T_A = +25^\circ\text{C}$, per channel, unless otherwise specified)

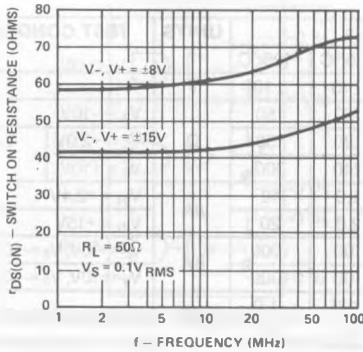
SWITCH-OFF ISOLATION REJECTION RATIO
—VS—
FREQUENCY



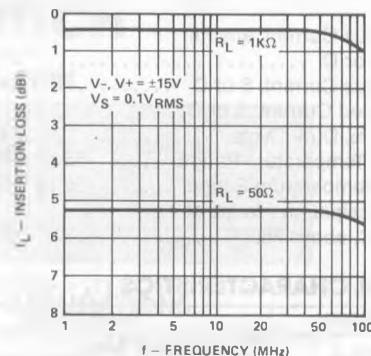
SWITCH ON RESISTANCE
—VS—
ANALOG VOLTAGE



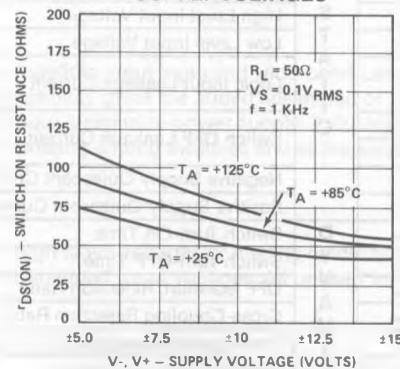
SWITCH-ON RESISTANCE
—VS—
FREQUENCY



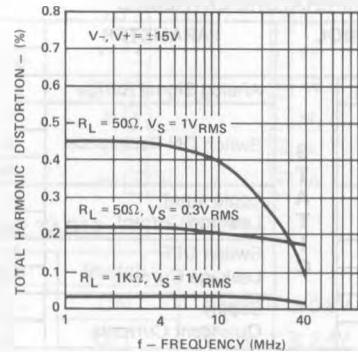
INSERTION LOSS
—VS—
FREQUENCY



SWITCH-ON RESISTANCE
—VS—
SUPPLY VOLTAGES

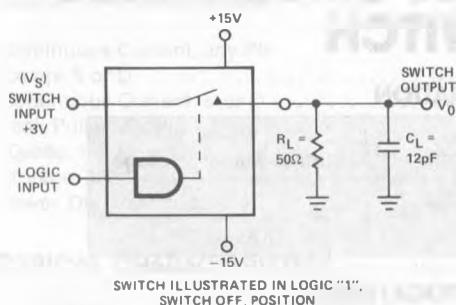


TOTAL HARMONIC DISTORTION
—VS—
FREQUENCY

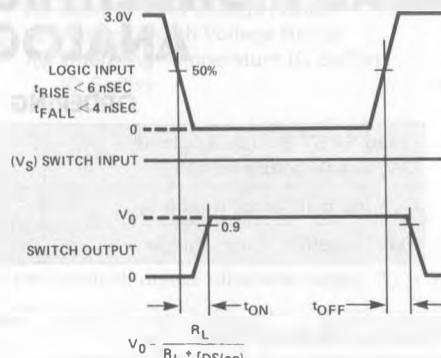


TYPICAL PERFORMANCE CHARACTERISTICS ($T_A = +25^\circ\text{C}$, per channel, unless otherwise specified)

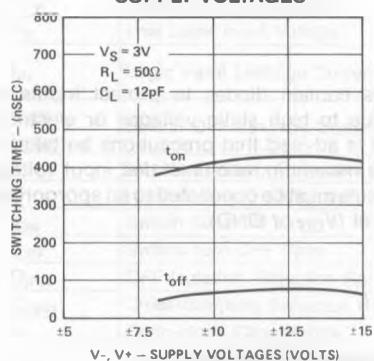
SWITCHING TIMES TEST CIRCUIT



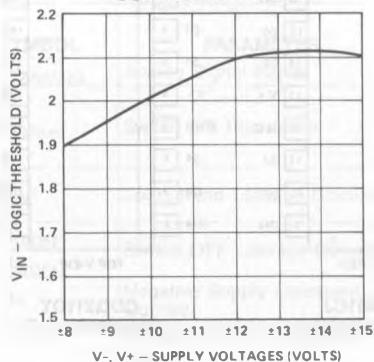
TEST WAVEFORMS



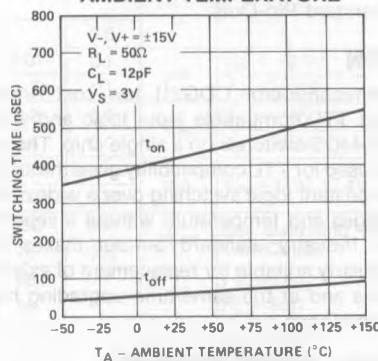
**SWITCHING TIMES
—VS—
SUPPLY VOLTAGES**



**LOGIC THRESHOLD
—VS—
SUPPLY VOLTAGES**



**SWITCHING TIMES
—VS—
AMBIENT TEMPERATURE**



**SUPPLY CURRENTS
—VS—
AMBIENT TEMPERATURE**

